

Search Notes

Application/Control No.

10/773,214

Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

WECK ET AL.

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
242	406 597.5 597.7 597.8	8/19/2005	JN
137	355.16	8/19/2005	JN
137	355.28	8/19/2005	JN
52	155	8/22/2005	JN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted exr. Yip (cl 52)	8/22/2005	JN